

Application/Control No.	Applicant(s)/Patent under Reexamination
10/657,645	HUSTED ET AL.
Examiner	Art Unit
Tam Nguyen	3764

	SEARCHED				
Class	Subclass	Date	Examiner		
482	51- 53,57,70, 79,80	2/24/2006	TN		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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